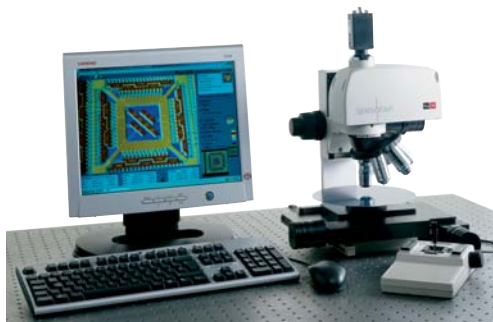


SENSOFAR®

SENSOFAR Wins Photonics Spectra's 2004 Circle of Excellence Award



Terrassa (Barcelona – Spain), January 25, 2005 – Sensofar-Tech, SL was honored with the 2004 Photonics Circle of Excellence Award, which is bestowed only to «the most technically innovative products of the year». The award ceremony was held on the 24th of January 2005, at the Fairmont Hotel in San Jose, CA, during 2005 Photonics West.

Sensofar was recognized for its innovative **PLμ 2300: Optical Imaging Profiler**, whose patented technology consists of a Dual-Technology sensor head that combines both confocal and interferometry techniques for non-contact measurement of the micro- and nano-geometry of technical surfaces.

The use of micro display technology and high power LED illumination on the Optical Imaging Profiler PLμ 2300 results in a significant breakthrough in non-contact optical profiling embodying a perfect combination of confocal microscopy, phase shift interferometry and vertical scanning interferometry in the same instrument, and offering a complete solution for a wide range of applications, such as: high aspect ratios and steep samples (MEMS), low reflective and rough surfaces (paper), nano-roughness and nano-features on dissimilar material samples (Semicon industry) or high local slopes in optically smooth and low reflective surfaces (micro-optics/micro-lenses), etc...

The product outperforms all existing systems through a unique combination of innovative technologies. In addition, it has a compact and robust design making the PLμ 2300 a complete tool which is ideal for obtaining a fast, non-invasive assessment of the micro- and nano-geometry of technical surfaces in multiple configurations: from a standard setup for R&D and quality inspection laboratories to a manipulator or robot driven system for online process controls and OEM applications.

«We are very honored to have been selected for this award. We understand the award as recognition of our continuous innovation effort,» said Ferran Laguarda, president of Sensofar. «The 2004 Photonics Circle of Excellence Award also confirms our position in the market and it will help us to reach the 30% market share of general purpose optical profilers».

Sensofar-Tech, SL is a spin-off company from the Technical University of Catalonia – Spain (UPC) whose mission is to successfully develop, produce and commercialize optical metrology tools and provide consulting within the field of optical metrology effectively using the philosophies of high quality, advanced techniques and accurate customer services. Founded in 2001, Sensofar is based in Terrassa (Barcelona – Spain) and has a team of international distributors covering the majority of the market. For additional information, visit the company website at www.sensofar.com.

